

GaN on SiC HEMT Pulsed Power Transistor 180 W Peak, 2700 to 3100 MHz, 300 µs Pulse, 10% Duty

Rev. V6

Features

- GaN Depletion Mode HEMT Microwave Transistor
- Common Source Configuration
- · Broadband Class AB Operation
- Thermally Enhanced Cu/Mo/Cu Package
- RoHS Compliant
- +50 V Typical Operation
- MTTF of 600 Years (T_{.1} < 200°C)
- EAR99 Export Classification

Applications

• Civilian and Military Pulsed Radar

Description

The MAGX-002731-180L00 and MAGX-002731-180L0S are gold metalized matched Gallium Nitride (GaN) on Silicon Carbide RF power transistors optimized for civilian and military radar pulsed applications between 2700 - 3100 MHz.

Using state of the art wafer fabrication processes, these high performance transistors provide high gain, efficiency, bandwidth, ruggedness over a wide bandwidth for today's demanding application needs.

The MAGX-002731-180L00 and MAGX-002731-180L0S are constructed using thermally enhanced Cu/Mo/Cu flanged ceramic packages which provide excellent thermal performance. High breakdown voltages allow for reliable and stable operation in extreme mismatched load conditions unparalleled with older semiconductor technologies.

MAGX-002731-180L00



MAGX-002731-180L0S



Ordering Information¹

Part Number	Package
MAGX-002731-180L00	Standard Flange
MAGX-002731-180L0S	Earless Flange
MAGX-S32731-180L00	2700 – 3100 MHz Evaluation Board

- When ordering the evaluation board, please indicate on sales order notes if it will be used for:
 - A. Standard Flange devices
 - B. Earless Flange devices



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Electrical Specifications²: 2700 - 3100 MHz, T_A = 25°C

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Units
RF Functional Tests: V _{DD} = 50 V, I _{DQ} = 500 mA, 300 μs Pulse, 10% Duty Cycle						
Output Power	P _{IN} = 14 Wpk	P _{OUT}	180	215	-	Wpk
Gain	P _{IN} = 14 Wpk	G _P	11.1	11.8	-	dB
Drain Efficiency	P _{IN} = 14 Wpk	η _D	43	51	-	%
Load Mismatch Stability	P _{IN} = 14 Wpk	VSWR-S	-	5:1	-	-
Load Mismatch Tolerance	P _{IN} = 14 Wpk	VSWR-T	-	10:1	-	-

^{2.} Typical RF performance measured in an RF evaluation board.

Electrical Characteristics: $T_A = 25$ °C

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Units
DC Characteristics						
Drain-Source Leakage Current	V _{GS} = -8 V, V _{DS} = 175 V	I _{DS}	-	-	12	mA
Gate Threshold Voltage	V _{DS} = 5 V, I _D = 30 mA	V _{GS (TH)}	-5	-3	-2	V
Forward Transconductance	V _{DS} = 5 V, I _D = 3.5 mA	G _M	5	-	-	S
Dynamic Characteristics						
Input Capacitance	N/A - Input Internally Matched	C _{ISS}	N/A	N/A	N/A	pF
Output Capacitance	V _{DS} = 50 V, V _{GS} = -8 V, F = 1 MHz	Coss	-	26.1	30.3	pF
Reverse Transfer Capacitance	V _{DS} = 50 V, V _{GS} = -8 V, F = 1 MHz	C _{RSS}	-	2.3	4.7	pF



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Absolute Maximum Ratings^{3,4,5}

Parameter	Absolute Maximum		
Drain Supply Voltage (V _{DD})	+65 V		
Gate Supply Voltage (V _{GG})	-8 V to 0 V		
Drain Supply Current (I _D)	10 A		
Input Power ⁶ (P _{IN})	P _{IN} (nominal) + 3 dB		
Operating Junction Temperature ⁷	250°C		
Peak Pulsed Power Dissipation @ 85°C	192 W		
Operating Temperature	-40°C to +85°C		
Storage Temperature	-65°C to +150°C		
ESD Min Charged Device Model (CDM)	350 V		
ESD Min Human Body Model (HBM)	550 V		
Maximum Solder Temperature	260°C		

^{3.} Exceeding any one or combination of these limits may cause permanent damage to this device.

Thermal Characteristics

Parameter	Test Conditions	Symbol	Typical	Units
Thermal Resistance	T_C = 85°C, V_{DD} = 50 V, I_{DQ} = 500 mA Pulse Width = 500 µs, Duty Cycle = 10%	Θ _{JC}	0.6	°C/W

^{4.} MACOM does not recommend sustained operation near these survivability limits.

^{5.} For saturated performance it is recommended that the sum of (3 * V_{DD} + $|V_{GG}|$) < 175 V.

^{6.} Input Power Limit is +3 dB over nominal drive required to achieve P_{OUT} = 180 W.

^{7.} Operating junction temperature is measured with infrared (IR) microscope. Junction temperature directly affects a device's MTTF and should be kept as low as possible to maximize lifetime.

[•] MTTF = 5.3×10^6 hours (T_J < 200° C)

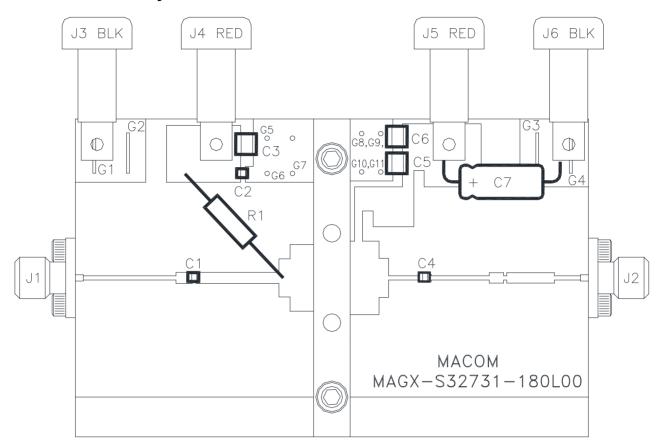
MTTF = 6.8 x 10⁴ hours (T_J < 250°C)



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Test Fixture Assembly



Parts List

Part	Description		
C1, C2, C4	Capacitor, 12 pF, 250 V, 5%, ATC800A		
C3, C5	Capacitor, 0.1 μF, 100 V, 10%, X7R, 0805, TDK		
C6	Capacitor, 1.0 μF, 100 V, 5%, 1206, Murata		
C7	Capacitor, 22 μF, 100 V, 20%, Panasonic		
R1	Resistor, 12 ohm, 1/4 W, 1%, Axial, Vishay Dale		
J1, J2	SMA Connector		
J3, J6	Female Banana Jack, Black		
J4, J5	Female Banana Jack, Red		
PCB	MACOM (Rogers RT6010.5LM, 0.25" thick, Er = 10.5)		



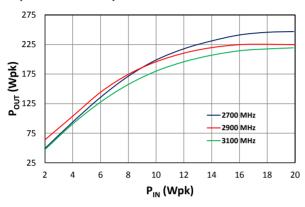
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Applications Section

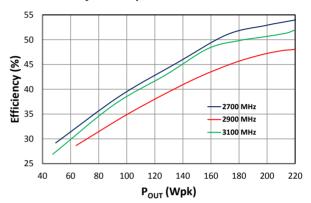
Typical Large-Signal Performance Curves

2700 - 3100 MHz, 300 μs Pulse, 10% Duty Cycle, V_{DD} = 50 V, I_{DQ} = 500 mA, P_{IN} = 14 Wpk, T_A = 25°C

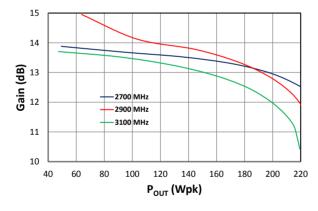
Output Power vs. Input Power



Drain Efficiency vs. Output Power



Gain vs. Output Power





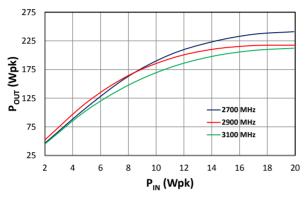
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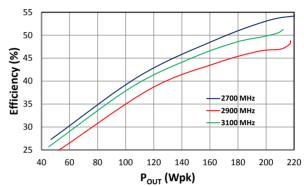
Typical Large-Signal Performance Curves

2700 - 3100 MHz, 500 μs Pulse, 10% Duty Cycle, V_{DD} = 50 V, I_{DQ} = 500 mA, P_{IN} = 14 Wpk, T_A = 25°C

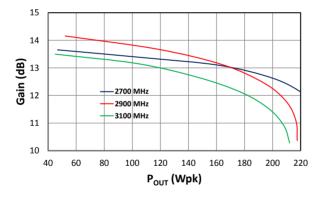
Output Power vs. Input Power



Drain Efficiency vs. Output Power



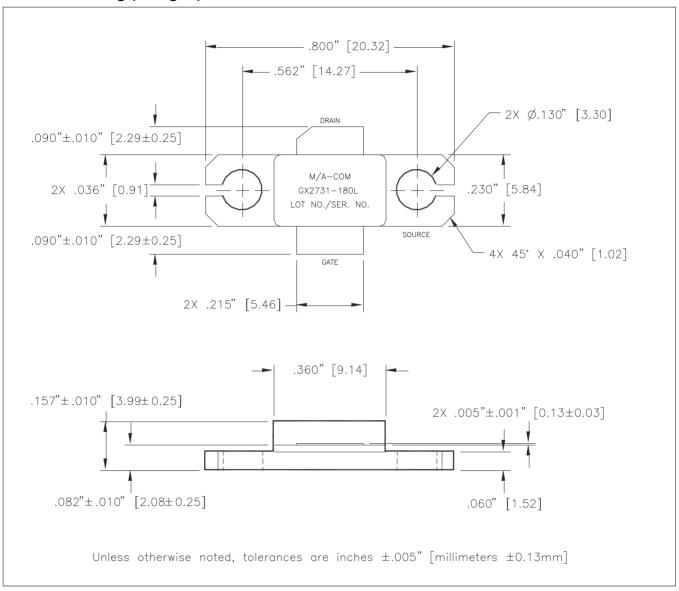
Gain vs. Output Power





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Outline Drawing (Flanged)



Bias Sequencing

TURNING THE DEVICE ON

- 1. Set V_{GS} to the pinch-off (V_P) , typically -5 V.
- 2. Turn on V_{DS} to nominal voltage (50 V).
- 3. Increase V_{GS} until the I_{DS} current is reached .
- 4. Apply RF power to desired level.

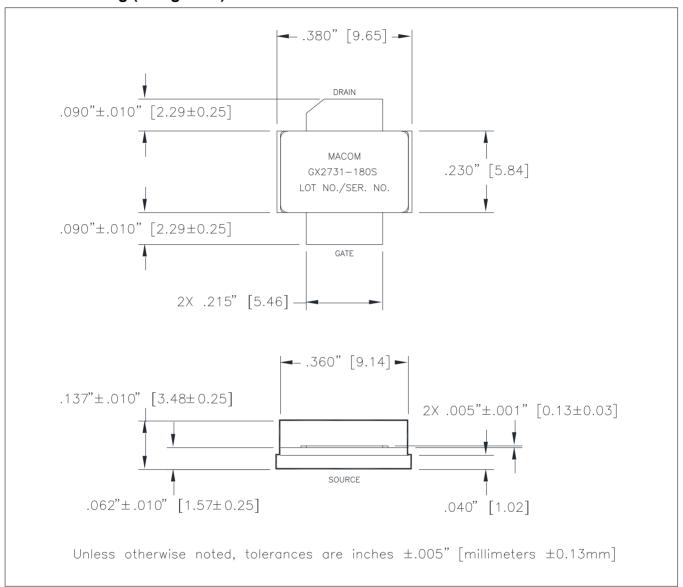
TURNING THE DEVICE OFF

- 1. Turn the RF power off.
- 2. Decrease V_{GS} down to $V_{P.}$
- 3. Decrease V_{DS} down to 0 V.
- 4. Turn off V_{GS}



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Outline Drawing (Flangeless)





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